## THE UNIVERSITY OF ADELAIDE

School of Electrical and Electronic Engineering

# Performance Evaluation of Measurement Algorithms used in IEDs

**Mohammad Nizam IBRAHIM** 

A thesis presented for the degree of Doctor of Philosophy

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### **Abstract**

Many Intelligent Electronic Devices (IEDs) are available for the protection of power systems. These IEDs use a series of mathematical algorithms for fault detection and execute various protection functions. The first and essential mathematical algorithm of any IED is the measurement algorithm. The aim of the measurement algorithm is to estimate the fundamental frequency component (phasor) of input current and voltage signals. Most protection algorithms use the estimated phasor for their executions. The most important factors for the successful use of the protection algorithms in IEDs are accuracy and speed of the phasor estimation by the measurement algorithms.

A fault in a power system produces step changes in the current and voltage phasors recorded by IEDs as well as a variety of nuisance signals. The nuisance signals introduce significant input distortions to measurement algorithms. Measurement algorithms that estimate the fundamental frequency phasor component from the distorted input signals produce some errors. Different measurement algorithms produce different amounts of

error. This is because their design is based on different approaches with different assumptions that result in different performance in the presence of nuisance signals.

It is important to evaluate the performance of measurement algorithms in the presence of nuisance signals. The evaluation is to ensure that measurement algorithms estimate the fundamental frequency component at the required design accuracy and speed. The result of the performance evaluation can be used to select appropriate measurement algorithms for specific protection applications. However, the parameters of nuisance signals are uncertain due to their dependence on unpredictable factors such as fault location and fault impedance. Thus, a methodology for the evaluation of measurement algorithm performance should take into account the uncertainty of the parameters of nuisance signals.

The traditional method of evaluating the performance of measurement algorithms is based on the local sensitivity method using a linear function approximation at a nominal point. The local sensitivity method varies only a single nuisance parameter (factor) while other factors are fixed at their nominal values. The studied factor is varied to observe errors in the output of the measurement algorithm. Such an approach, however, does not provide the overall performance of measurement algorithms. Besides, varying the single factor does not represent realistic scenarios.

This thesis proposes a new methodology to evaluate the performance of measurement algorithms implemented in IEDs. The proposed methodology uses the global uncertainty and sensitivity analysis method. In this method, all factors representing nuisance components are varied simultaneously. Uncertainty analysis measures the uncertainty in output of the measurement algorithm due to the uncertainty of input factors. Sensitivity analysis measures the contribution of all factors and their interactions to output uncertainty.

In general, the global uncertainty and sensitivity method that is based on the Monte Carlo approach requires extensive evaluations. Its implementation can be prohibitive, particularly in practical testing, because the number of factors is large. Thus, a two-stage methodology with a significantly smaller number of evaluations is used. The first-stage is the use of the Morris method as a preliminary (screening of factors) sensitivity analysis and

the second-stage is the implementation of the Extended Fourier Amplitude Sensitivity Test (EFAST) technique for comprehensive global uncertainty and sensitivity analysis. A single evaluation involves one run of the IED injection test which can take a few minutes. Thus, it is justifiable to search for the methodology that is uses the smaller number of evaluations.

The proposed methodology contributes to an automated testing method integrating ATP/EMTP, MATLAB and SIMLAB programs as well as the injection test facility. The ATP/EMTP program is used to generate fault test scenarios. The MATLAB program is used to model elements of the IED to calculate performance indices on the output of measurement algorithms and automatically control the process of extensive evaluations (simulations). The main role of the SIMLAB is to analyze the uncertainty and sensitivity of the measurement algorithms outputs.

The proposed methodology has been demonstrated by evaluating the performance of a known measurement algorithm in simulation and an unknown measurement algorithm of a commercial IED (SEL-421). The methodology has been successfully performed in the simulation as well as in practical testing. The results of the analysis indicate that the performance is typically most sensitive to a few parameters out of many possible factors. These important parameters should then be the focus of research for the optimization of measurement algorithms.

### **Declaration and Publications**

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#### **List of Publications**

(P1) Ibrahim, M.N.; Zivanovic, R.; "An advanced method for evaluation of measurement algorithms used in digital protective relaying," *Power Engineering Conference*, 2009 (AUPEC 2009). Australasian Universities on, vol., no., pp.1-6, Adelaide, Australia, 27-30 Sept. 2009.

- (P2) Ibrahim, M.N.; Rohadi, N.; Zivanovic, R.; "Methodology for automated testing of transmission line fault locator algorithms," *Power Engineering Conference*, 2009 (AUPEC 2009). Australasian Universities on, vol., no., pp.1-4, Adelaide, Australia, 27-30 Sept. 2009.
- (P3) Ibrahim, M.N.; Zivanovic, R.; "Impact of CVT transient on measurement algorithms implemented in digital protective relays," *Electrical Energy and Industrial Electronic Systems (EEIES 2009), International Conference on*, vol., no., pp.1-6, Penang, Malaysia, 7-8 December 2009.
- (P4) Ibrahim, M.N.; Zivanovic, R.; "Impact of CT saturation on phasor measurement algorithms: Uncertainty and sensitivity study," *Probabilistic Methods Applied to Power Systems (PMAPS 2010), 2010 IEEE 11th International Conference on*, vol., no., pp.728-733, Singapore, 14-17 June 2010.
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Signed:	Date:

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## **Symbols**

 $\Delta V$  Voltage amplitude change

C Equivalent capacitance

 $EE_i(X)$  Elementary effect of changing the  $i^{th}$  input factor

 $f_c$  Cut-off frequency

 $f_c$  Frequency response of measurement algorithm

 $f_{max}$  Maximum frequency  $f_{min}$  Minimum frequency

FRI Ideal/benchmark frequency response

F<sub>L</sub> Fault location

 $h_3$  Amplitude of third harmonic  $h_5$  Amplitude of fifth harmonic  $G_1, G_2$  Equivalent generator 1 and 2 H The highest harmonic order

j Integer frequency

L Equivalent inductance

 $L_C$  Compensation inductance

 $L_G$  Number of grid level

 $L_M$  Magnetizing inductance

 $L_P$  Primary leakage inductance

 $L_{\rm S}$  Secondary leakage inductance

Number of sample per cycle

*N*<sub>S</sub> Number of simulation

N1: N2 Turn ratio

 $O_S$  Overshoot

p(X) Probability distribution of X

 $PI_{DC}$  Performance index for DC amplitude attenuation

 $PI_{FA}$  Performance index for fundamental aggregate criterion

 $PI_{H3}$  Performance index for third harmonic amplitude attenuation

 $PI_{H5}$  Performance index for fifth harmonic amplitude attenuation

R Equivalent resistance

 $R_F$  Fault resistance

 $R_M$  Magnetizing resistance

 $R_P$  Primary winding resistance

 $R_S$  Secondary winding resistance

*U*<sub>S</sub> Undershoot

s Scalar variable

Sample of signals,  $k = 1,2,3....\infty$ 

 $S_i$  Imaginary part of the fundamental frequency

 $S_r$  Real part of the fundamental frequency

 $S_{se}$  Steady state error

 $SI_i$  Sensitivity index for  $i^{th}$  factor

 $SI_{i,j}$  Sensitivity index for interaction of  $i^{th}$  and  $j^{th}$  factor

 $SI_{i,total}$  Total sensitivity index for  $i^{th}$  factor

 $T_S$  Settling time

 $x_n$   $n^{th}$  nuisance factor

 $V_i$  Variance contributed by  $i^{th}$  factor

 $V_{i,j}$  Variance contributed by interaction of i and j factor

 $V_{\sim i}$  Variance contributed by other than  $i^{th}$  factor

 $V_{group}$  Variance contributed by a group of factors

 $V_{total}$  Total variance

ω Angular frequency

 $\bar{y}$  Output mean value

ZB Burden of CT

α Amplitude of decaying DC offset

au Time constant of decaying DC offset

λ Remanent flux

 $\delta f_1$  Off-nominal fundamental frequency

β Fault inception angle

 $y_{true}$  True value of fundamental frequency amplitude

 $y_{max}$  The maximum value of estimated fundamental frequency

 $y_{min}$  The minimum value of estimated fundamental frequency

 $y_{\infty}$  Steady state value of fundamental frequency amplitude

 $\mu$  Mean of error value

 $\sigma$  Standard deviation of error

 $min_{error}$ Minimum of error $max_{error}$ Maximum of error

Δ Predetermined pertubation

 $A_j$  Fourier cosine

 $B_i$  Fourier sine

 $\Lambda_i$  Variance spectrum

### **Abbreviations**

A/D Analogue to Digital Converter

ATP Alternative Transient Program

ANOVA Analysis of Variance

CB Circuit Breaker

CT Current Transformer

COMTRADE Common Transient Data Exchange

CVT Capacitive Voltage Transformer

DFT Discrete Fourier Transform

EFAST Extended Fourier Amplitude Sensitivity Test

EHV Extra High Voltage

EMTP Electromagnetic Transient Program
FAST Fourier Amplitude Sensitivity Test

FIR Finite Impulse Response

FSC Ferro-resonant Suppression Circuit

GPS Global Positioning System

LHS Latin Hypercube Sampling

IED Intelligent Electronic Device

IIR Infinite Impulse Response

LPF Low Pass Filter

MC Monte Carlo

OAT One Factor At A Time

PDF Probability Distribution Function

PMU Phasor Measurement Unit

PPE Percentage peak error

PRMSE Percentage root-mean-square error

p.u. Per unit

QMC Quasi-Monte Carlo

RL Resistor-Inductor Element

RMS Root-mean-square

RRTS Remote Relay Test System

SA Sensitivity Analysis

SIR Source to Impedance Ratio

TSM Taylor Series Method

TVE Total Vector Error

U Uniform distribution function

UA Uncertainty Analysis

VT Voltage Transformer